



NOTES

1. DESIGN WAVELENGTH: 355 nm
2. CLEAR APERTURE: >90%CA
3. SURFACE QUALITY (S1, S2) : 40/20 (S/D)
4. SURFACE FLATNESS (S1, S2) :  $\lambda/10@632.8 \text{ nm}$
5. PARALLELISM (S1, S2) : <5 arcsec
6. CHAMFER: <0.2 mm, 45°
7. AR COATING (S1, S2) :  $R_{avg} < 0.2 \% @ 355 \text{ nm}$ , 0° AOI, Single Surface

DRAWING PROJECTION			<b>LBTEK</b>			
	NAME	DATE				
DRAWN	SHAN	SEP./11th/25	FLAT WINDOW			
APPROVAL	WCHENG	SEP./11th/25	MATERIAL	WEIGHT	SCALE	REV
FOR INFORMATION ONLY NOT FOR MANUFACTURING PURPOSES			UVFS	3.34g	2:1	A